Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/509,195	CHRISTENSEN, LEIF
Examiner	Art Unit

Francis T. Palo

3644

	SEAR	CHED	
Class	Subclass	Date	Examiner
		·	
		·	
,			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u></u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			,
,		DATE	EXMR
Updated Search		10/26/2007	FP
		·	
	<del></del>		
,		١	
	٠		
			,